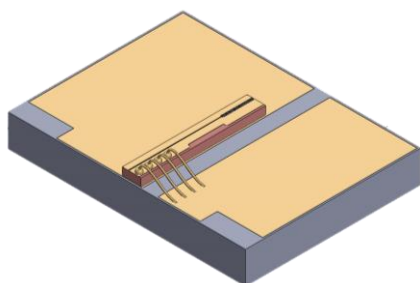
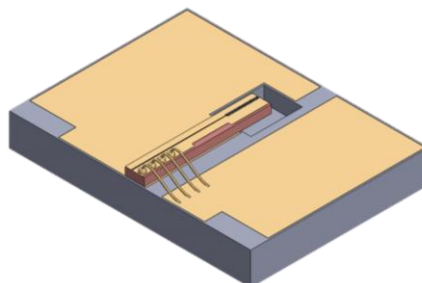


Specification Sheet | 852.347 nm Series

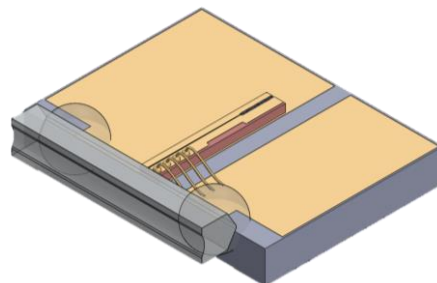
Distributed Bragg Reflector (DBR) Laser Diode



Chip on Submount (CoS)



CoS + Mode-Hop Free (MHF)



CoS + Virtual Point Source (VPS) Lens

Description

The 852.347 nm DBR Series of high-performance edge-emitting laser diodes are based on Photodigm's advanced monolithic single-frequency Gallium Arsenide (GaAs) based laser technology. It provides a single spatial mode beam and has passivated facets for reliability. The 852.347 nm Series DBR devices are used in atomic spectroscopy for cesium-based (Cs) applications as well as Raman spectroscopy. The 852.347 nm Series DBR devices are Spectroscopy Certified; guaranteed to hit the Cs D2 transition ± 10 °C from room temperature.

852.347 nm DBR Chip on Submount (CoS) Characteristics

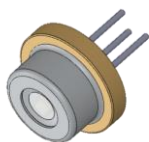
Parameters ¹	Chip Architecture		
	HOT ³ (High Operating Temperature)	Low Power	High Power
Wavelength, Nominal (nm) ²	852.347 \pm 0.6		
Power Range (mW)	10–30	40–80	80–240
Operating Current, Max (CW & Pulsed) (mA)	90	140	350
Optical Power at Max Operating Current (mW)	30	80	240
Slope Efficiency, Nominal (W/A)	0.6	0.9	0.9
Threshold Current, Nominal (mA)	40	30	50

1. Characteristics at T_c = 25 °C unless otherwise specified. Operating outside of these parameters voids warranty.

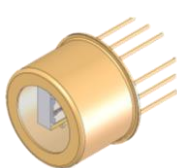
2. Hermetically sealed packages may contain CoS that are ± 1.2 nm from nominal.

3. HOT characteristics specified at 65 °C.

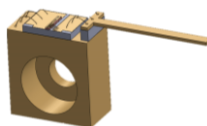
Available Free-Space Package Add-ons



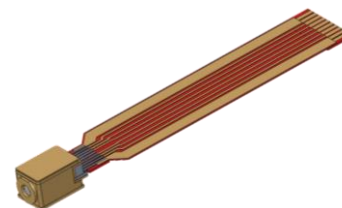
9MM



TO-8



C-Mount



Transmitter Optical Subassembly (TOSA)

Specification Sheet | 852.347 nm Series

Distributed Bragg Reflector (DBR) Laser Diode

Specifications

Laser

Parameter	Unit	Min	Typical	Max
Storage Temperature	°C	0	-	70
Operating Temperature at case	°C	5	-	70
Operating Temperature at laser chip ¹	°C	5	-	45
Laser Series Resistance	Ω	-	2	-
Laser Forward Voltage @ LIV Current	V	-	2	-
Nominal Laser Linewidth @ LIV Current	kHz	-	500	-
Beam Divergence @ FWHM ($\theta_{ }$ x θ_{\perp})	°	-	6 x 28	8 x 32
Side Mode Suppression Ratio (SMSR)	dB	-	-40	-
Polarization Extinction Ratio	dB	-17	-20	-
Laser Polarization	TE			
Mode Structure	Fundamental Mode			
Temperature Tuning Rate	nm/°C	-	0.06	-
Current Tuning Rate	nm/mA	-	0.002	-
Laser Reverse Voltage	V	-	-	0

1. Operation below dew point not recommended without hermetically sealed packaged

Free-Space Package Add-Ons

Parameter	Unit	Min	Typical	Max
Photodiode Forward Current	mA	-	-	10
Photodiode Reverse Voltage	V	-	-	50
TEC Current (TOSA)	A	-1.1	-	1.1
TEC Voltage (TOSA)	V	-3.0	-	3.0
TEC Current (TO-8)	A	-1.8	-	1.8
TEC Voltage (TO-8)	V	-2.2	-	2.2
Thermistor Resistance	kΩ	-	10	-

Handling Precautions

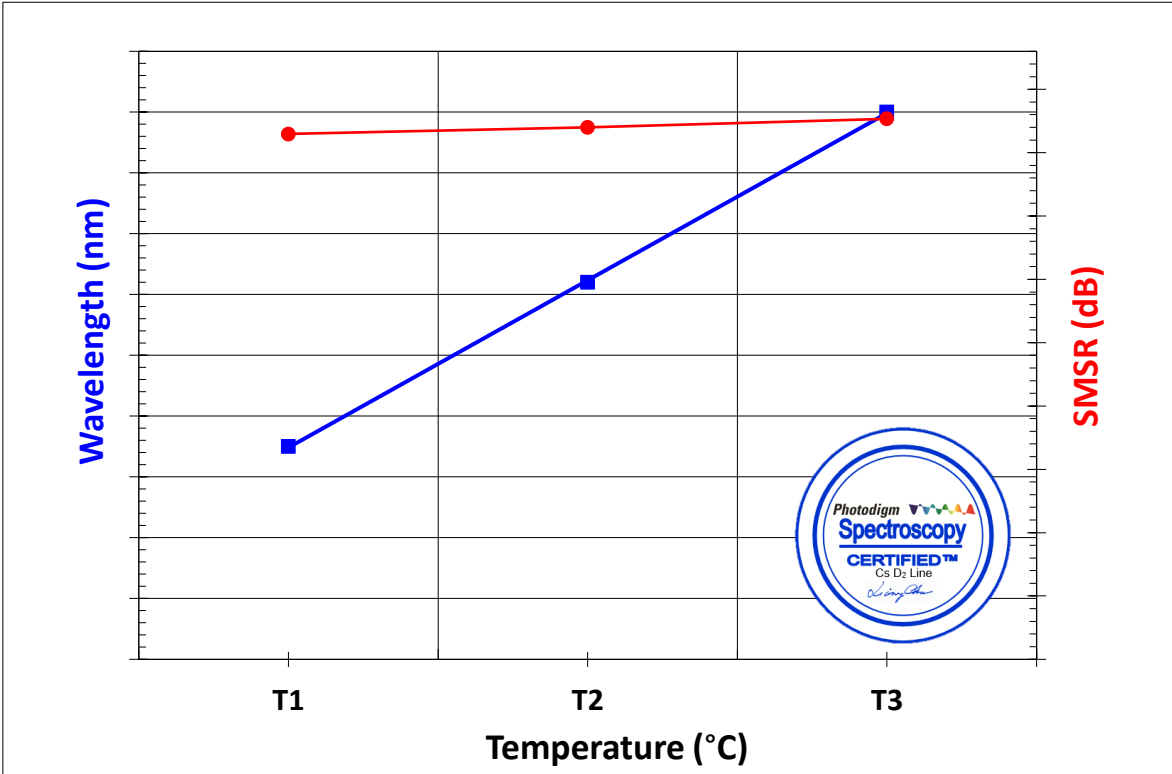
These devices are sensitive to ESD. When handling the module, grounded work area and wrist strap must be used. Always store in an antistatic container with all leads shorted together.



Photodigm, Inc. reserves the right to make changes in design, specifications, and other information at any time, and without prior notice. The information contained within the specification sheet is believed to be accurate. However, no responsibility is assumed for possible inaccuracy or omission. Any information contained herein shall not legally bind Photodigm, Inc. unless it is specifically incorporated in the terms and conditions of a sales agreement.

Specification Sheet | **852.347 nm Series**
Distributed Bragg Reflector (DBR) Laser Diode

Air Wavelength Characteristics at Constant Current and Temperature



LIV Characteristics by Current

